



DC SPECIFICATIONS AT Ta = 25 °C

SYMBOL	PARAMETERS AND CONDITIONS	UNITS	MIN	TYP	MAX
I_{dss}	Saturated Drain Current $V_{ds} = 3.0\text{ V}$ $V_{GS} = 0.0\text{ V}$	mA	18		66
G_m	Transconductance $V_{ds} = 3.0\text{ V}$ $V_{GS} = 0.0\text{ V}$	mS	27	35	
V_p	Pinch-off Voltage $V_{ds} = 3.0\text{ V}$ $I_{DS} = 1.0\text{ mA}$	V		-1.5	-4.0
BV_{GSO}	Gate-to-Source Breakdown Voltage $I_{gs} = -0.2\text{ mA}$, $I_{gd} = 0$	V	-5.0	-8.0	
BV_{GDO}	Gate-to-Drain Breakdown Voltage $I_{gd} = -0.2\text{ mA}$, $I_{gs} = 0$	V	-6.0	-8.0	
R_{th}	Thermal Resistance MwT-4 Chip MwT-470, 473	°C/W			250 460*

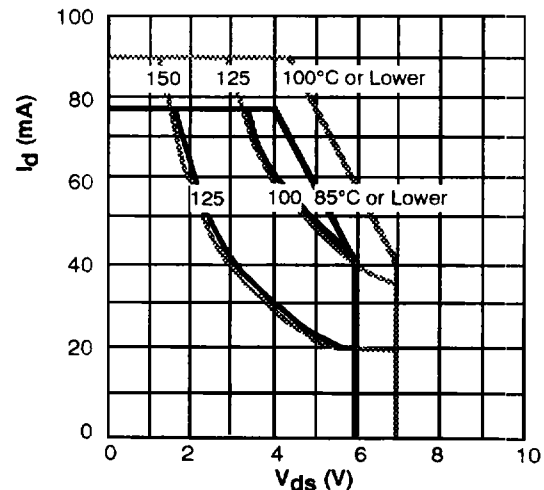
* Overall R_{th} depends on case mounting

MAXIMUM RATINGS AT Ta = 25 °C

SYMBOL	PARAMETER	UNITS	CONT MAX ¹	ABSOLUTE MAX ²
V_{DS}	Drain to Source Voltage	V	See Safe Operating Limits	
T_{ch}	Channel Temperature	°C	+150	+175
T_{st}	Storage Temperature	°C	-65 to +150	+175
P_{in}	RF Input Power	mW	90	180

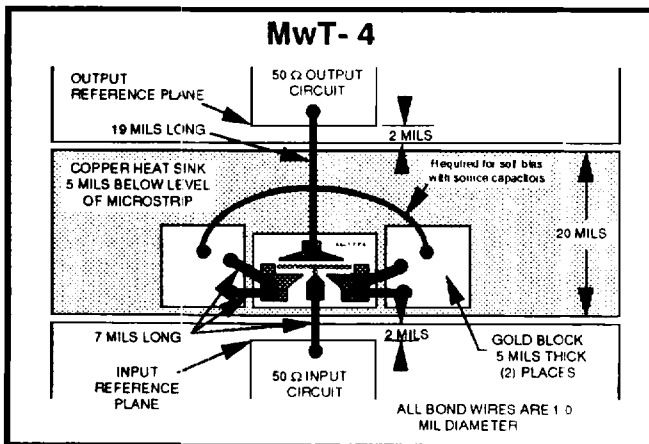
- NOTES: 1. Exceeding any one of these limits in continuous operation may reduce the mean-time-to-failure below the design goals.
2. Exceeding any one of these limits may cause permanent damage.

SAFE OPERATING LIMITS
vs. Case Temperature

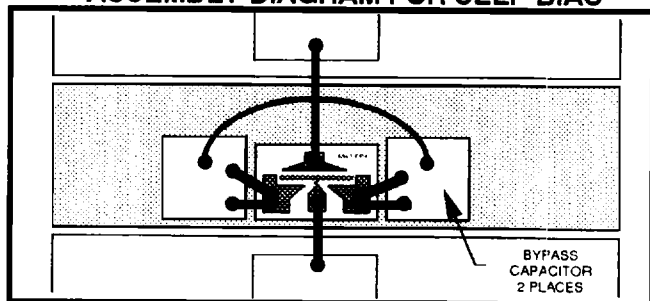


RECOMMENDED ASSEMBLY CONFIGURATION

Shown below is the assembly and bonding configuration used for S-Parameter measurements of the MwT-4 Chip and is recommended for optimum performance. For self-bias applications the gold blocks may be replaced by capacitors. An additional interconnecting bond would then be required. Contact MwT for additional applications information.



ASSEMBLY DIAGRAM FOR SELF-BIAS



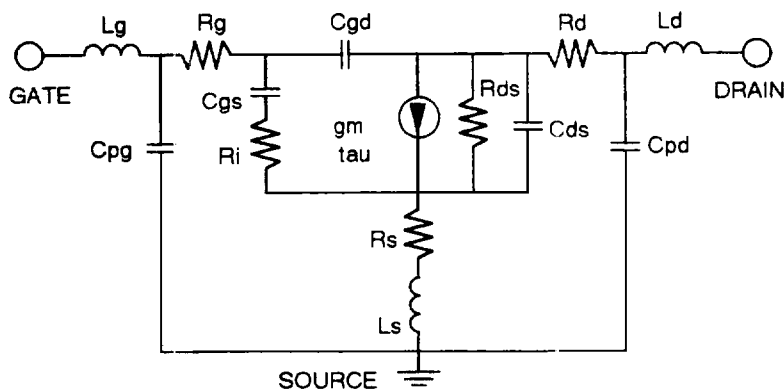


TYPICAL COMMON SOURCE SCATTERING PARAMETERS

MwT-4 CHIP: VDS = 4.5 V, IDS = 0.5 IDSS = 18 mA

FREQUENCY (GHz)	S11		S21		S12		S22	
	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG
1.00	.99	-11.8	3.13	169.6	.01	82.8	.74	-5.3
2.00	.99	-23.4	3.08	159.3	.03	75.8	.74	-10.5
3.00	.97	-34.7	3.01	149.2	.04	68.9	.72	-15.6
4.00	.95	-45.5	2.92	139.5	.05	62.5	.70	-20.5
5.00	.93	-55.9	2.81	130.2	.06	56.4	.68	-25.2
6.00	.90	-65.8	2.69	121.2	.07	50.7	.66	-29.8
7.00	.88	-75.1	2.58	112.7	.08	45.4	.64	-34.2
8.00	.86	-83.8	2.46	104.6	.09	40.5	.62	-38.5
9.00	.83	-92.1	2.35	96.8	.10	35.9	.59	-42.8
10.00	.81	-99.8	2.24	89.3	.10	31.7	.57	-47.2
12.00	.78	-113.9	2.05	75.2	.11	24.0	.53	-56.1
14.00	.75	-126.5	1.88	61.9	.12	17.2	.49	-65.6
16.00	.73	-137.7	1.74	49.3	.12	10.9	.45	-76.7
18.00	.71	-147.9	1.61	37.2	.12	5.2	.41	-89.3
20.00	.70	-157.0	1.49	25.3	.13	-0.3	.38	-103.8
22.00	.69	-165.4	1.39	13.8	.13	-5.6	.36	-120.5
24.00	.68	-173.0	1.29	2.5	.13	-10.6	.36	-138.9
26.00	.68	-180.0	1.20	-8.7	.13	-15.6	.37	-157.8

DEVICE EQUIVALENT CIRCUIT MODEL



PARAMETER		VALUE
Gate Bond Wire Inductance	Lg	.11 nH
Gate Pad Capacitance	Cpg	.07 pF
Gate Resistance	Rg	.13 Ω
Gate-Source Capacitance	Cgs	.22 pF
Channel Resistance	Ri	10.8 Ω
Gate-Drain Capacitance	Cgd	.02 pF
Transconductance	gm	44 mS
Transit time	tau	2.66 psec
Source Resistance	Rs	4.08Ω
Source Inductance	Ls	.03 nH
Drain-Source Resistance	Rds	283 Ω
Drain-Source Capacitance	Cds	.054 pF
Drain Resistance	Rd	6.99 Ω
Drain Pad Capacitance	Cpd	.04 pF
Drain Inductance	Ld	.27 nH

BIN SELECTION

Every MwT-4 wafer produced is 100% DC probed, binned by Idss in 3 ma increments, and sample devices are evaluated for RF performance. Users may select devices from 16 Idss bins to insure consistent matched performance in the circuit. Availability in three visual grades insures the most economical solution for the application.

BIN #	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16
IDSS (mA)	15-21	21-24	24-27	27-30	30-33	33-36	36-39	39-42	42-45	45-48	48-51	51-54	54-57	57-60	60-63	63-66



MwT-4
26 GHz Low Noise
GaAs FET

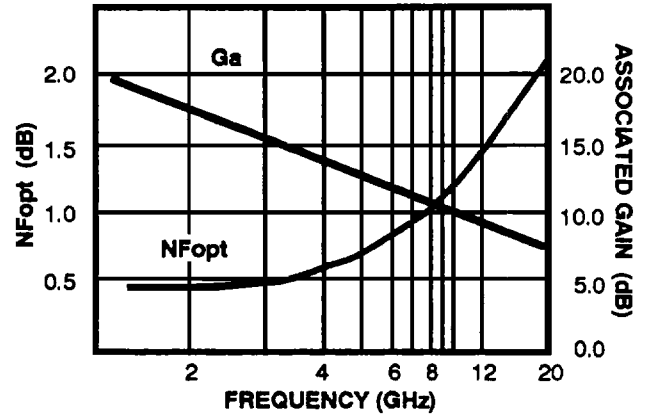


TYPICAL NOISE PARAMETERS

MwT-4LN Chip: VDS = 3.0 V, IDS = 10 mA

FREQUENCY MHz	NF MIN dB	GAMMA OPT		Rn/50
		MAG	ANGLE	
1.00	0.38	0.95	4.5	0.94
2.00	0.40	0.90	15.5	0.83
4.00	0.64	0.76	31.4	0.53
6.00	0.86	0.64	48.0	0.43
8.00	1.07	0.54	66.1	0.38
12.00	1.47	0.42	107.1	0.32
16.00	1.83	0.40	148.7	0.29
18.00	2.00	0.42	166.4	0.28
20.00	2.16	0.46	-178.5	0.26

NOISE FIGURE AND ASSOCIATED GAIN VS. FREQUENCY



TYPICAL COMMON SOURCE SCATTERING PARAMETERS

MwT-473: VDS = 4.0 V, IDS = 0.5 IDSS = 22 mA

FREQUENCY (GHz)	S11		S21		S12		S22	
	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG
1.00	.97	-23.1	2.86	160.2	.01	73.3	.79	-15.5
2.00	.91	-41.4	2.50	144.1	.03	58.8	.76	-28.3
3.00	.86	-54.2	2.20	131.8	.03	62.3	.74	-38.2
4.00	.81	-65.2	2.14	121.6	.05	47.6	.70	-47.8
5.00	.74	-72.9	2.14	114.3	.04	39.2	.66	-53.5
6.00	.69	-88.3	2.16	101.8	.06	58.5	.63	-63.5
8.00	.58	-135.6	2.33	79.0	.07	13.6	.49	-85.5
10.00	.68	-172.9	2.16	51.7	.05	-6.4	.45	-114.4
12.00	.76	171.0	1.94	34.0	.03	9.8	.49	-142.1
14.00	.72	151.0	1.73	-0.2	.05	-2.1	.60	-168.4
16.00	.57	116.8	1.62	-27.7	.07	-0.6	.76	176.8
18.00	.63	70.1	1.83	-66.4	.10	1.5	.84	161.8

MwT-470: VDS = 3.0 V, IDS = 0.5 IDSS = 12 mA

FREQUENCY (GHz)	S11		S21		S12		S22	
	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG
1.00	.98	-19.1	2.5	158.2	.02	73.4	.80	-14.2
2.00	.93	-34.7	2.22	140.8	.03	56.0	.78	-25.2
3.00	.87	-47.3	1.98	128.0	.04	56.0	.76	-32.9
4.00	.81	-57.9	1.82	119.4	.06	70.6	.74	-38.4
5.00	.77	-70.1	1.82	111.3	.07	34.6	.70	-43.5
6.00	.72	-82.8	1.83	102.4	.08	28.9	.65	-49.4
7.00	.66	-100.1	1.92	90.4	.09	22.0	.57	-57.9
8.00	.62	-119.8	1.93	78.9	.11	6.0	.47	-67.6
9.00	.62	-142.2	1.82	67.2	.08	-16.1	.41	-90.4
10.00	.62	-153.7	1.84	51.2	.09	-2.5	.38	-105.8
11.00	.69	-167.3	1.69	40.5	.08	-16.5	.42	-126.0
12.00	.74	-178.7	1.62	30.8	.06	-17.6	.49	-137.9
13.00	.82	170.3	1.52	18.4	.08	-10.8	.55	-151.4
14.00	.90	159.0	1.60	15.4	.09	-29.4	.56	-164.2

